

RoHS Compliant Product
A Suffix of "-C" specifies halogen & lead-free

DESCRIPTIONS

The SSI318-C is the highest performance trench N-Ch MOSFETs with extreme high cell density, which provide excellent $R_{DS(ON)}$ and gate charge for most of the synchronous buck converter applications.

The SSI318-C meet the RoHS and Green Product requirement with full function reliability approved.

FEATURES

- Reliable and Rugged
- Green Device Available
- ESD Protection

MARKING

318

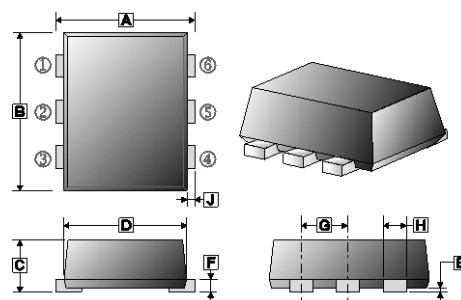
PACKAGE INFORMATION

Package	MPQ	Leader Size
SOT-563	3K	7 inch

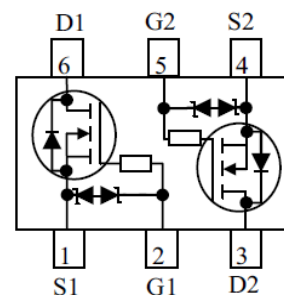
ORDER INFORMATION

Part Number	Type
SSI318-C	Lead (Pb)-free and Halogen-free

SOT-563



REF.	Millimeter		REF.	Millimeter	
	Min.	Max.		Min.	Max.
A	1.50	1.70	F	0.09	0.16
B	1.50	1.70	G	0.45	0.55
C	0.525	0.60	H	0.17	0.27
D	1.10	1.30	J	0.10	0.30
E	-	0.05			



ABSOLUTE MAXIMUM RATINGS

Parameter	Symbol	Ratings	Unit
Drain-Source Voltage	V_{DS}	60	V
Gate-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current ¹ , @ $V_{GS}=4.5V$	I_D	$T_A=25^\circ C$	0.25
		$T_A=85^\circ C$	0.18
Pulsed Drain Current ²	I_{DM}	1	A
Power Dissipation	P_D	150	mW
Operating Junction & Storage Temperature Range	T_J, T_{STG}	-55~150	$^\circ C$
Thermal Resistance Ratings			
Thermal Resistance Junction-Ambient ¹	$R_{\theta JA}$	833	$^\circ C/W$

ELECTRICAL CHARACTERISTICS ($T_J=25^\circ\text{C}$ unless otherwise specified)

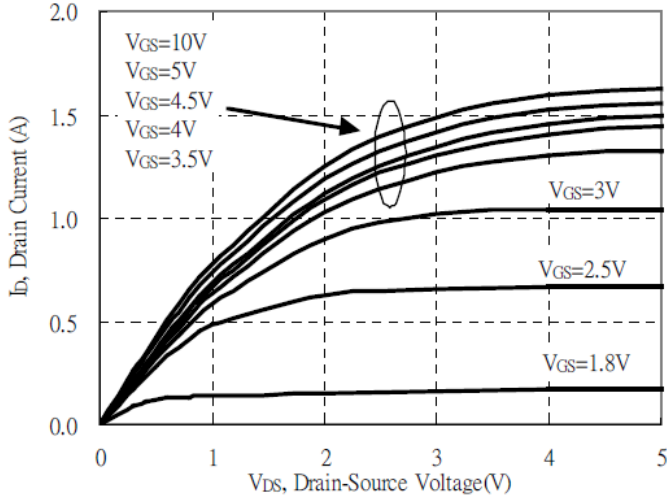
Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions	
Drain-Source Breakdown Voltage	BV_{DSS}	50	-	-	V	$V_{GS}=0, I_D=250\mu\text{A}$	
Gate Threshold Voltage	$V_{GS(th)}$	0.5	-	1.5	V	$V_{DS}=V_{GS}, I_D=1\text{mA}$	
Gate-Source Leakage Current	I_{GSS}	-	-	± 10	μA	$V_{GS}= \pm 16\text{V}$	
Drain-Source Leakage Current	I_{DSS}	$T_J=25^\circ\text{C}$	-	-	1	μA	$V_{DS}=48\text{V}, V_{GS}=0$
		$T_J=55^\circ\text{C}$	-	-	10		$V_{DS}=48\text{V}, V_{GS}=0$
Static Drain-Source On-Resistance ³	$R_{DS(ON)}$		-	-	1.6	Ω	$V_{GS}=10\text{V}, I_D=220\text{mA}$
			-	-	2		$V_{GS}=4.5\text{V}, I_D=220\text{mA}$
			-	-	4.5		$V_{GS}=2.5\text{V}, I_D=120\text{mA}$
Total Gate Charge	Q_g	-	0.69	-	nC	$I_{DS}=100\text{mA}$ $V_{DS}=30\text{V}$ $V_{GS}=4.5\text{V}$	
Gate-Source Charge	Q_{gs}	-	0.3	-			
Gate-Drain ("Miller") Charge	Q_{gd}	-	0.18	-			
Turn-on Delay Time	$T_{d(on)}$	-	7	-	nS	$V_{DD}=30\text{V}$ $I_{DS}=100\text{mA}$ $V_{GS}=4.5\text{V}$ $R_{GEN}=10\Omega$	
Rise Time	T_r	-	6.6	-			
Turn-off Delay Time	$T_{d(off)}$	-	20	-			
Fall Time	T_f	-	80	-			
Input Capacitance	C_{iss}	-	27	-	pF	$V_{GS}=0$ $V_{DS}=25\text{V}$ $f=1\text{MHz}$	
Output Capacitance	C_{oss}	-	13	-			
Reverse Transfer Capacitance	C_{rss}	-	6	-			
Source-Drain Diode							
Continuous Source Current ¹	I_S	-	-	0.25	A		
Pulsed Source Current ²	I_{SM}	-	-	1	A		
Diode Forward Voltage ³	V_{SD}	-	-	1.2	V	$I_S=200\text{mA}, V_{GS}=0$	

Notes:

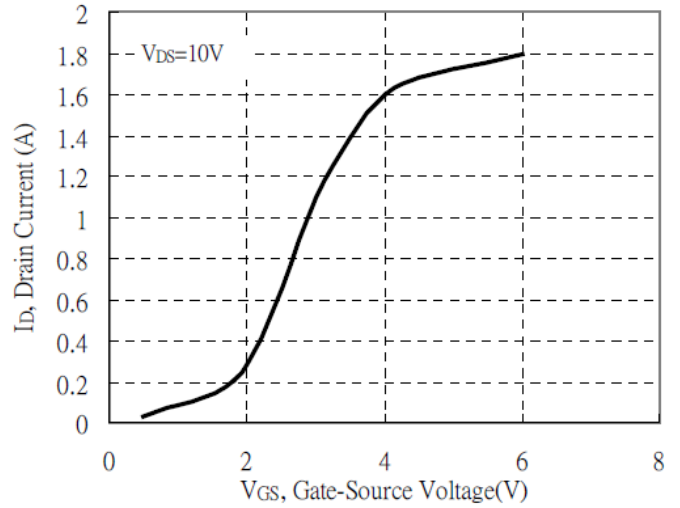
- Surface mounted on FR4 board.
- Pulse width limited by maximum junction temperature, $P_w \leq 300\mu\text{s}$, Duty cycle $\leq 1\%$.
- The data tested by pulsed, pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$.

CHARACTERISTIC CURVES

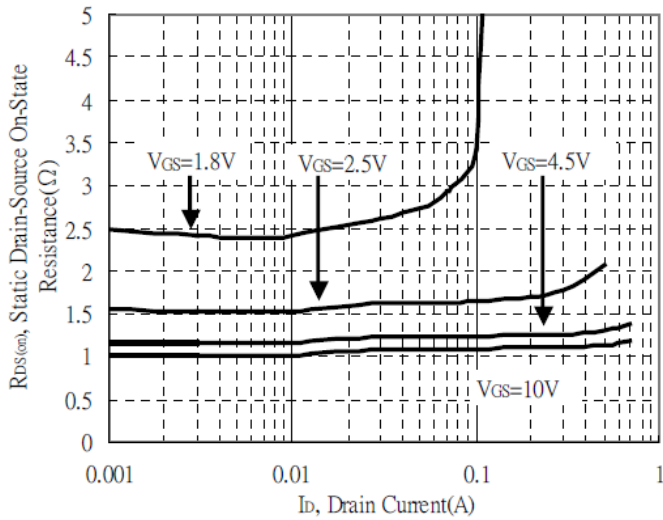
Typical Output Characteristics



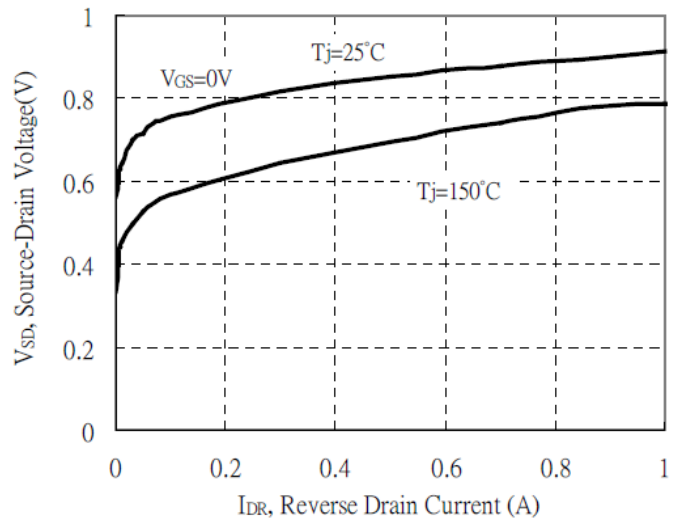
Typical Transfer Characteristics



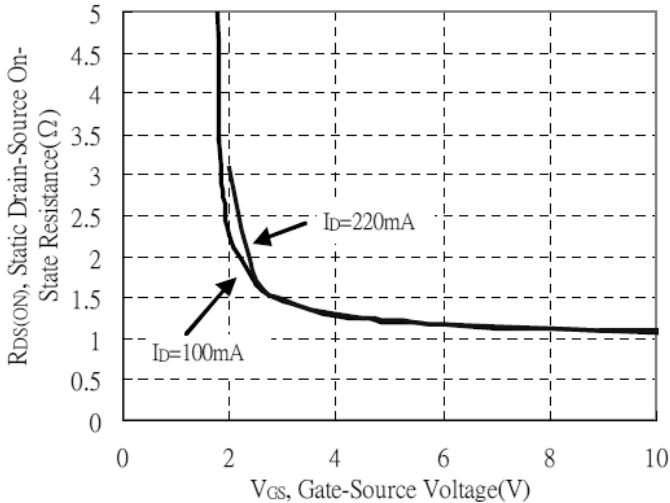
Static Drain-Source On-State resistance vs Drain Current



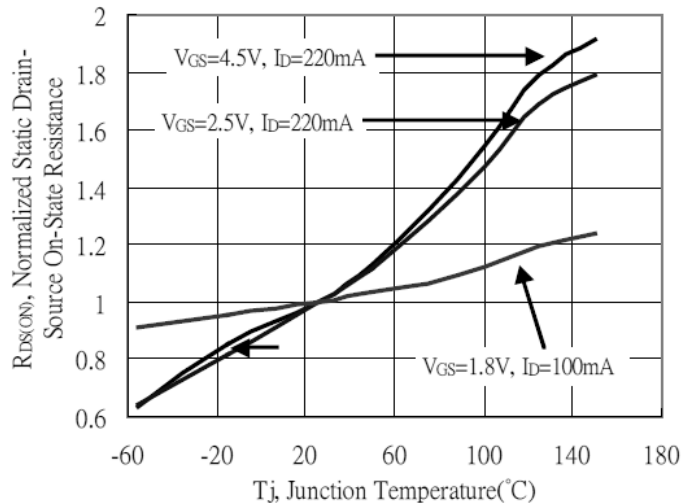
Reverse Drain Current vs Source-Drain Voltage



Static Drain-Source On-State Resistance vs Gate-Source Voltage

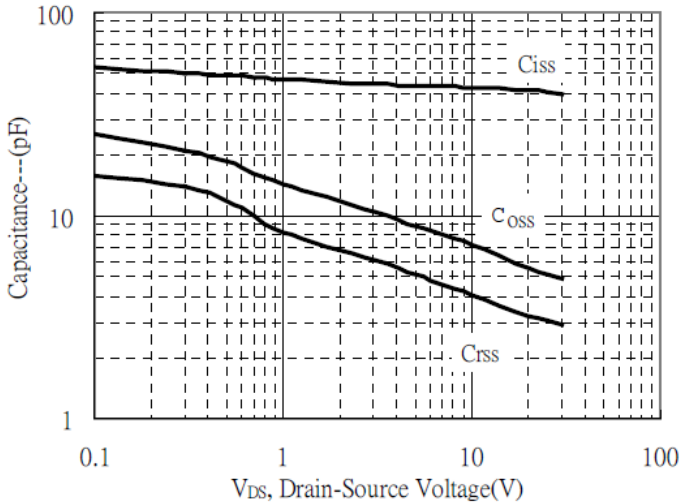


Drain-Source On-State Resistance vs Junction Temperature

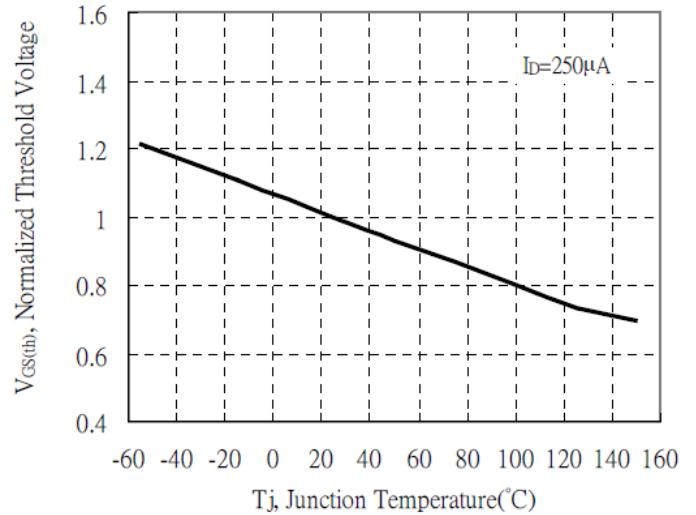


CHARACTERISTIC CURVES

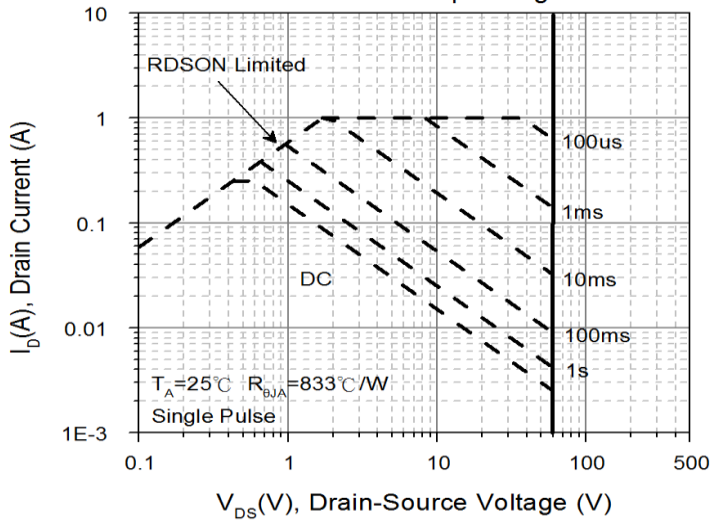
Capacitance vs Drain-to-Source Voltage



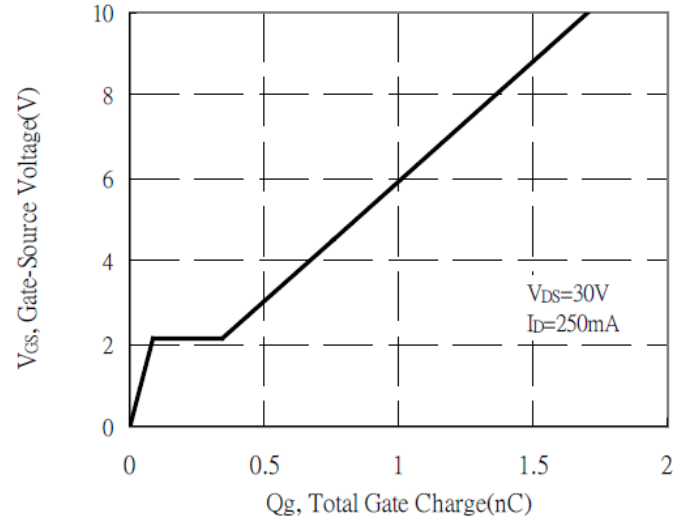
Threshold Voltage vs Junction Temperature



Maximum Safe Operating Area



Gate Charge Characteristics



Transient Thermal Response Curves

